

Application/Control No.	Applicant(s)/Patent under Reexamination
10/038,169	BONEH ET AL.
Examiner	Art Unit
Baotran N. To	2135

SEARCHED					
Class	Subclass	Date	Examiner		
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INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner		

SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
EAST SEARCH	8/18/2006	вт		
(Consulted with Ponnoreay Pich)	8/18/2006	ВТ		
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